Cool MOS™ Power Transistor

COOLMOS Power Semiconductors

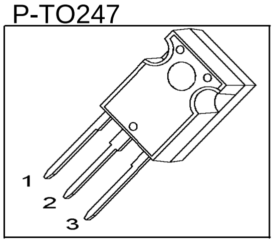
Feature

- New revolutionary high voltage technology
- Worldwide best $R_{DS(on)}$ in TO 220
- Ultra low gate charge
- Periodic avalanche rated
- Extreme d*v*/d*t* rated
- High peak current capability
- Improved transconductance
- 150 °C operating temperature

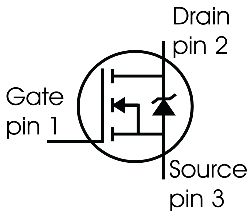
Product Summary

V_{DS} @ T_{jmax}	650	V
$R_{DS(on)}$	0.19	Ω
I_D	20.7	A

P-TO247



Type	Package	Ordering Code	Marking
SPW20N60C3	P-TO247	Q67040-S4406	20N60C3



Maximum Ratings, at T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Value	Unit
Continuous drain current T_C = 25 °C T_C = 100 °C	I_D	 20.7 13.1	A
Pulsed drain current, t_p limited by T_{jmax}	$I_{D\ puls}$	62.1	
Avalanche energy, single pulse I_D=10A, V_{DD}=50V	E_{AS}	690	mJ
Avalanche energy, repetitive t_{AR} limited by T_{jmax} 1) I_D=20A, V_{DD}=50V	E_{AR}	1	
Avalanche current, repetitive t_{AR} limited by T_{jmax}	I_{AR}	20	A
Reverse diode d*v*/d*t* I_S=20.7A, $V_{DS} < V_{DD}$, d*i*/d*t*=100A/µs, T_{jmax}=150°C	d*v*/d*t*	6	V/ns
Gate source voltage static	V_{GS}	±20	V
Gate source voltage dynamic	V_{GS}	±30	
Power dissipation, T_C = 25°C	P_{tot}	208	W
Operating and storage temperature	T_j , T_{stg}	-55... +150	°C

Thermal Characteristics

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Characteristics					
Thermal resistance, junction - case	R_{thJC}	-	-	0.6	K/W
Thermal resistance, junction - ambient, leaded	R_{thJA}	-	-	62	
Linear derating factor		-	-	1.67	W/K
Soldering temperature, 1.6 mm (0.063 in.) from case for 10s	T_{sold}	-	-	260	°C

Electrical Characteristics, at T_j = 25 °C, unless otherwise specified

Parameter	Symbol	min.	typ.	max.	Unit
Static Characteristics					
Drain-source breakdown voltage V_{GS}=0V, I_D=0.25mA	$V_{(BR)DSS}$	600	-	-	V
Drain-source avalanche breakdown voltage V_{GS}=0V, I_D=20A	$V_{(BR)DS}$	-	700	-	
Gate threshold voltage, $V_{GS} = V_{DS}$ I_D = 1 mA	$V_{GS(th)}$	2.1	3	3.9	
Zero gate voltage drain current	I_{DSS}				µA
V_{DS} = 600 V, V_{GS} = 0 V, T_j = 25 °C		-	0.5	25	
V_{DS} = 600 V, V_{GS} = 0 V, T_j = 150 °C		-	-	250	
Gate-source leakage current V_{GS}=20V, V_{DS}=0V	I_{GSS}	-	-	100	nA
Drain-source on-state resistance	$R_{DS(on)}$				Ω
V_{GS}=10V, I_D=13.1A, T_j=25°C		-	0.16	0.19	
V_{GS}=10V, I_D=13.1A, T_j=150°C		-	0.54	0.64	
Gate input resistance f = 1 MHz, open drain	R_G	-	0.54	-	

[1]Repetitve avalanche causes additional power losses that can be calculated as $P_{AV}=E_{AR}*f$.

Electrical Characteristics , at T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Characteristics						
Transconductance	g_{fs}	V_{DS}≥2*I_D*$R_{DS(on)max}$, I_D=13.1A	-	17.5	-	S
Input capacitance	C_{iss}	V_{GS}=0V, V_{DS}=25V, f=1MHz	-	3000	-	pF
Output capacitance	C_{oss}		-	1170	-	
Reverse transfer capacitance	C_{rss}		-	40	-	
Effective output capacitance,[1] energy related	$C_{o(er)}$	V_{GS}=0V, V_{DS}=0V to 480V	-	83	-	pF
Effective output capacitance,[2] time related	$C_{o(tr)}$		-	160	-	
Turn-on delay time	$t_{d(on)}$	V_{DD}=380V, V_{GS}=0/13V, I_D=20.7A, R_G=3.6Ω, T_j=125	-	10	-	ns
Rise time	t_r	V_{DD}=380V, V_{GS}=0/13V, I_D=20.7A, R_G=3.6Ω	-	5	-	
Turn-off delay time	$t_{d(off)}$		-	67	100	
Fall time	t_f		-	4.5	12	

Gate Charge Characteristics

Gate to source charge	Q_{gs}	V_{DD}=480V, I_D=20.7A	-	11	-	nC
Gate to drain charge	Q_{gd}		-	33	-	
Gate charge total	Q_g	V_{DD}=480V, I_D=20.7A, V_{GS}=0 to 10V	-	87	114	
Gate plateau voltage	$V_{(plateau)}$	V_{DD}=480V, I_D=20.7A	-	5.5	-	V

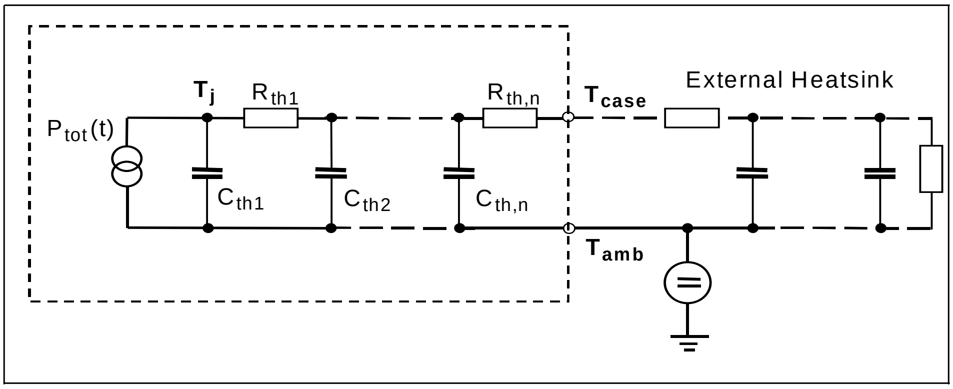
[1] $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
[2] $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.

Electrical Characteristics, at T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Characteristics						
Inverse diode continuous forward current	I_S	T_C=25°C	-	-	20.7	A
Inverse diode direct current, pulsed	I_{SM}		-	-	62.1	
Inverse diode forward voltage	V_{SD}	V_{GS}=0V, I_F=I_S	-	1	1.2	V
Reverse recovery time	t_{rr}	V_R=480V, I_F=I_S , di_F/dt=100A/µs	-	500	800	ns
Reverse recovery charge	Q_{rr}		-	11	-	µC
Peak reverse recovery current	I_{rrm}		-	70	-	A
Peak rate of fall of reverse recovery current	di_{rr}/dt		-	1400	-	A/µs

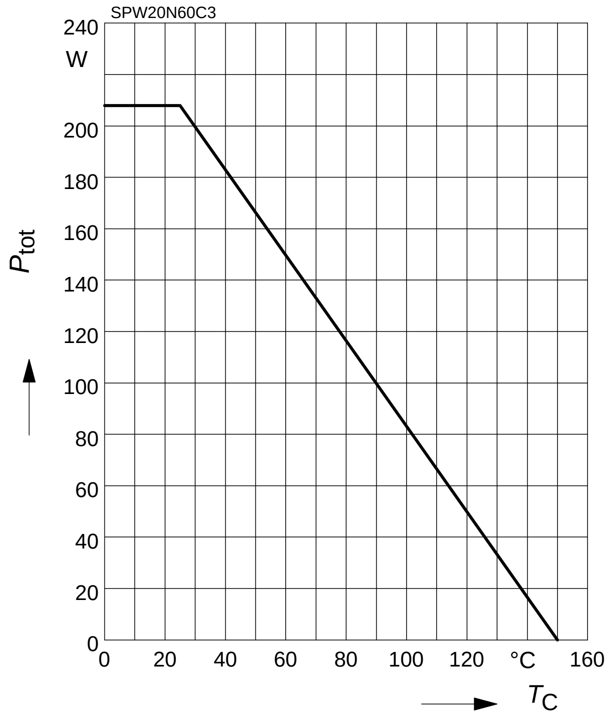
Transient Thermal Characteristics

Symbol	Value	Unit	Symbol	Value	Unit
	typ.			typ.	
Thermal resistance			Thermal capacitance		
R_{th1}	0.00746	K/W	C_{th1}	0.000439	Ws/K
R_{th2}	0.017		C_{th2}	0.00145	
R_{th3}	0.028		C_{th3}	0.00239	
R_{th4}	0.065		C_{th4}	0.00499	
R_{th5}	0.081		C_{th5}	0.021	
R_{th6}	0.037		C_{th6}	0.146	



1 Power dissipation

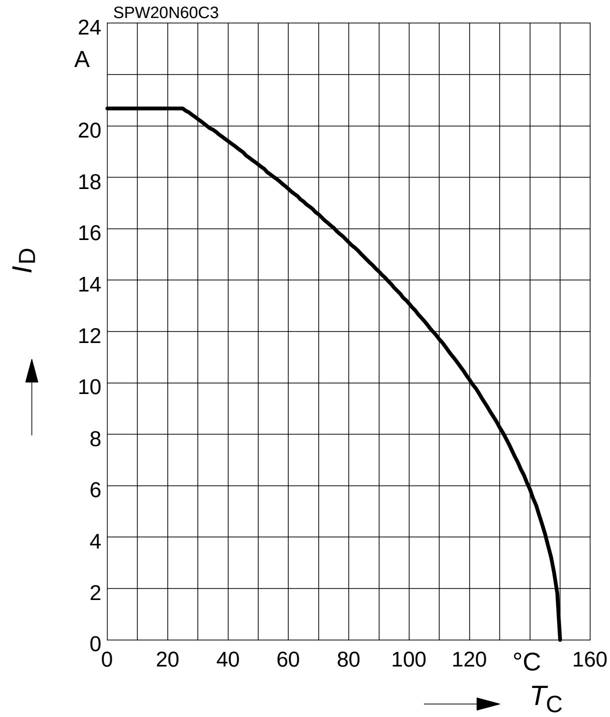
$P_{tot} = f(T_C)$



2 Drain current

$I_D = f(T_C)$

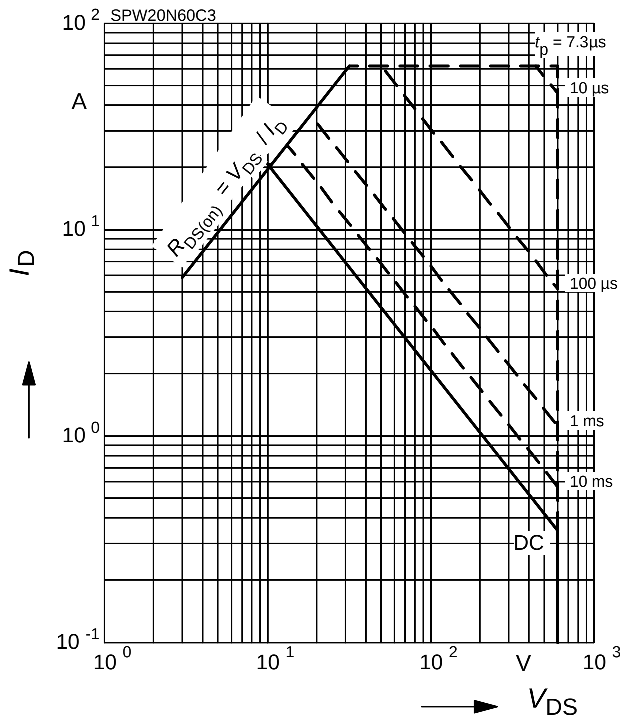
parameter: $V_{GS} \geq 10$ V



3 Safe operating area

$I_D = f(V_{DS})$

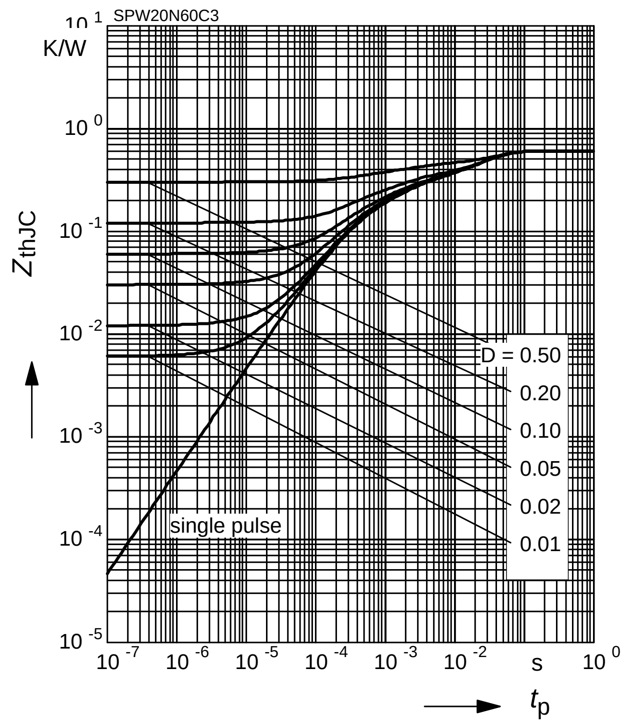
parameter : $D = 0$, T_C=25°C



4 Transient thermal impedance

$Z_{thJC} = f(t_p)$

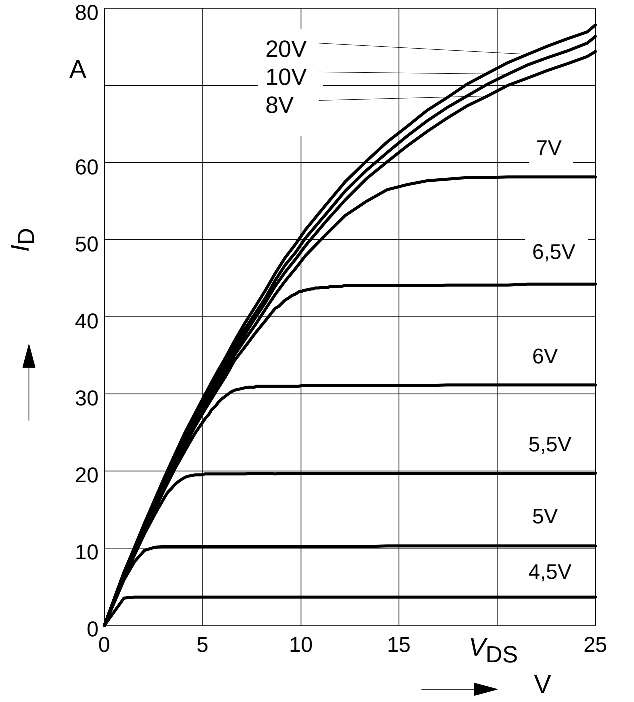
parameter : $D = t_p/T$



5 Typ. output characteristic

$I_D = f(V_{DS})$; T_j=25°C

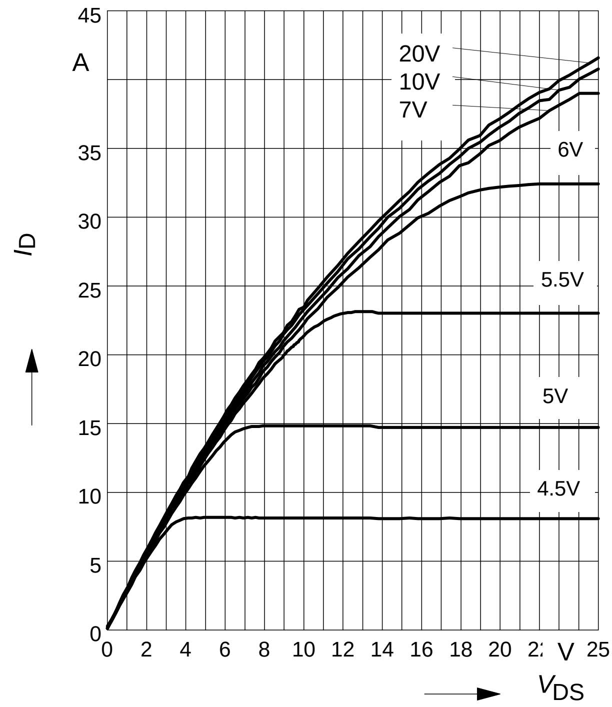
parameter: t_p = 10 µs, V_{GS}



6 Typ. output characteristic

$I_D = f(V_{DS})$; T_j=150°C

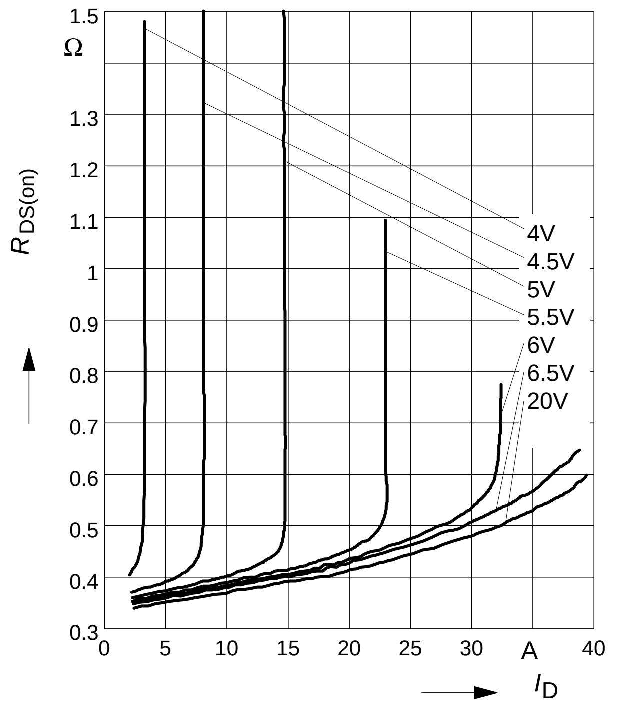
parameter: t_p = 10 µs, V_{GS}



7 Typ. drain-source on resistance

$R_{DS(on)}=f(I_D)$

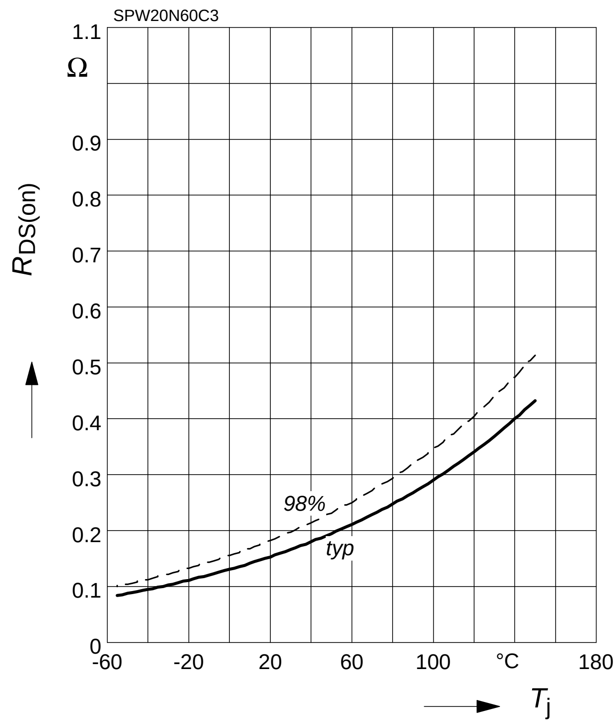
parameter: T_j=150°C, V_{GS}



8 Drain-source on-state resistance

$R_{DS(on)} = f(T_j)$

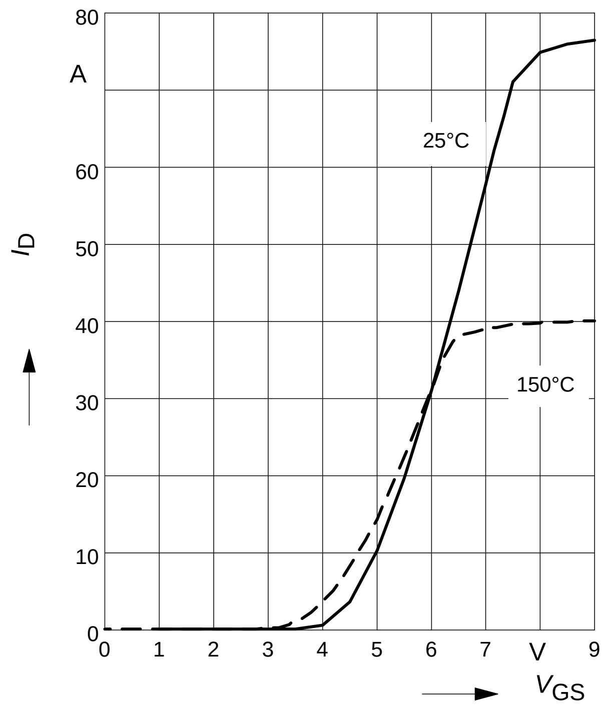
parameter : I_D = 13.1 A, V_{GS} = 10 V



9 Typ. transfer characteristics

$I_D = f(V_{GS})$; $V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$

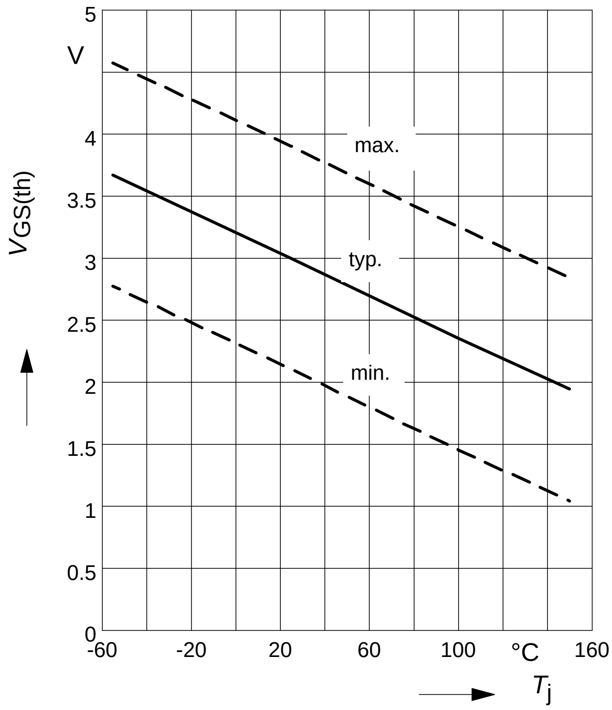
parameter: t_p = 10 µs



10 Gate threshold voltage

$V_{GS(th)} = f(T_j)$

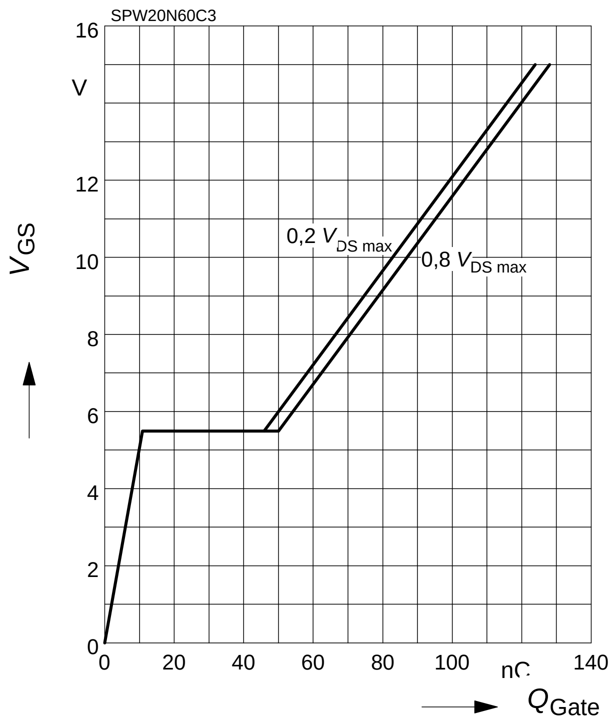
parameter: $V_{GS} = V_{DS}$, I_D = 1 mA



11 Typ. gate charge

$V_{GS} = f(Q_{Gate})$

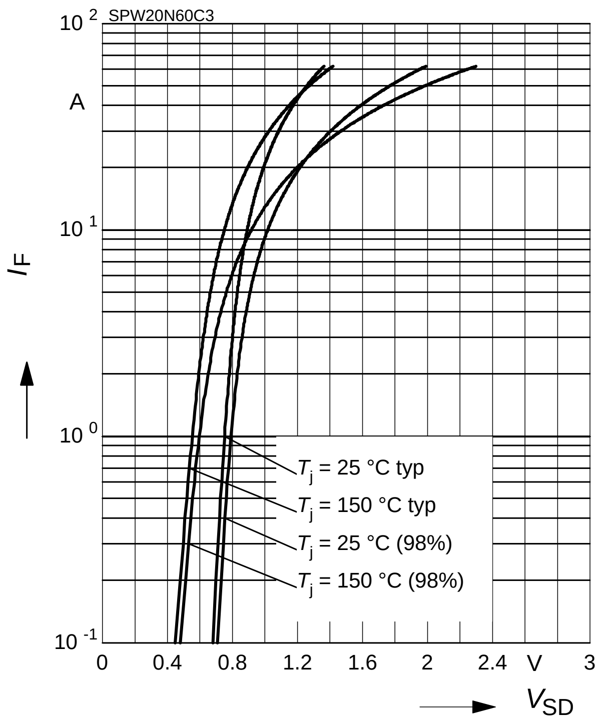
parameter: I_D = 20.7 A pulsed



12 Forward characteristics of body diode

$I_F = f(V_{SD})$

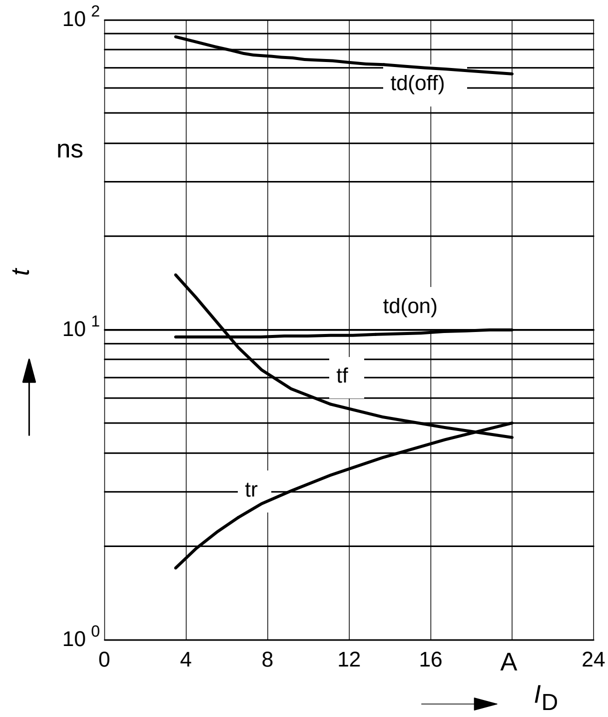
parameter: T_j , t_p = 10 µs



3.6 Typ. switching time

$t = f(I_D)$, inductive load, T_j=125°C

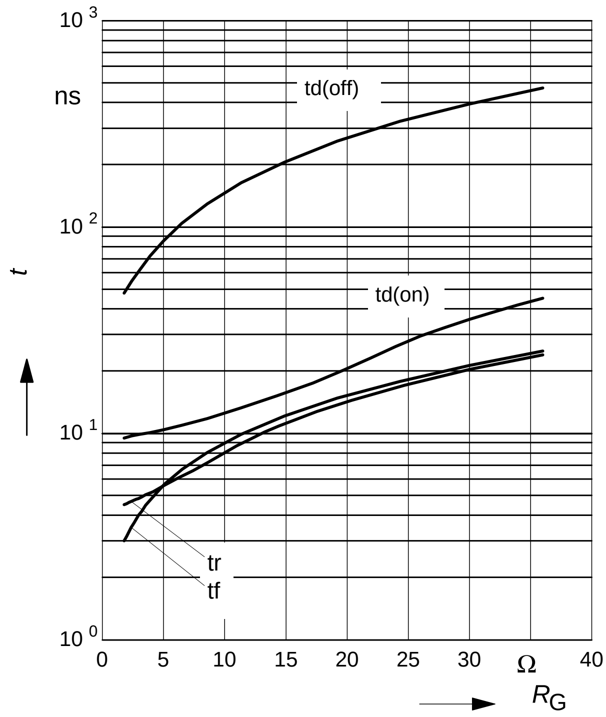
par.: V_{DS}=380V, V_{GS}=0/+13V, R_G=3.6Ω



13 Typ. switching time

$t = f(R_G)$, inductive load, T_j=125°C

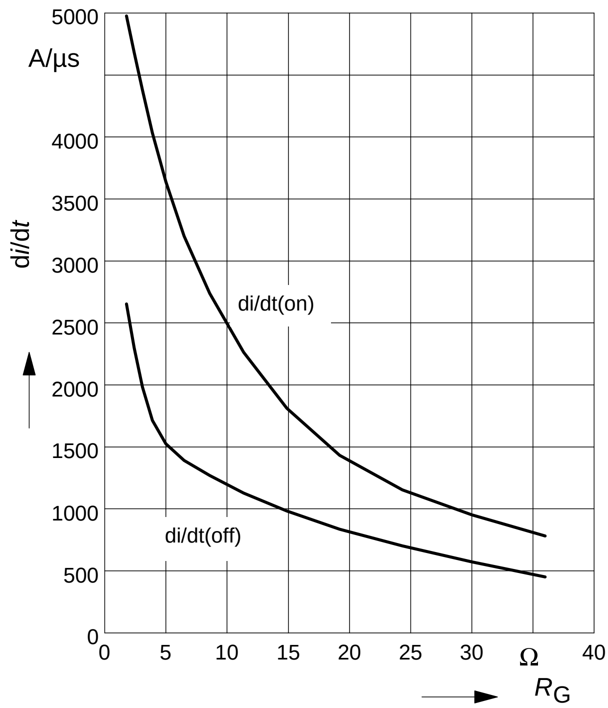
par.: V_{DS}=380V, V_{GS}=0/+13V, I_D=20.7 A



14 Typ. drain current slope

di/dt = f(R_G), inductive load, T_j = 125°C

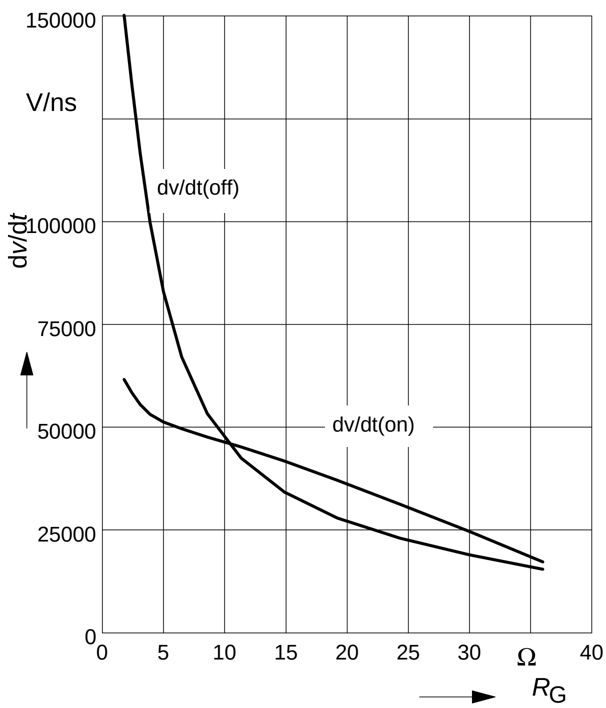
par.: V_{DS}=380V, V_{GS}=0/+13V, I_D=20.7A



15 Typ. drain source voltage slope

di/dt = f(R_G), inductive load, T_j = 125°C

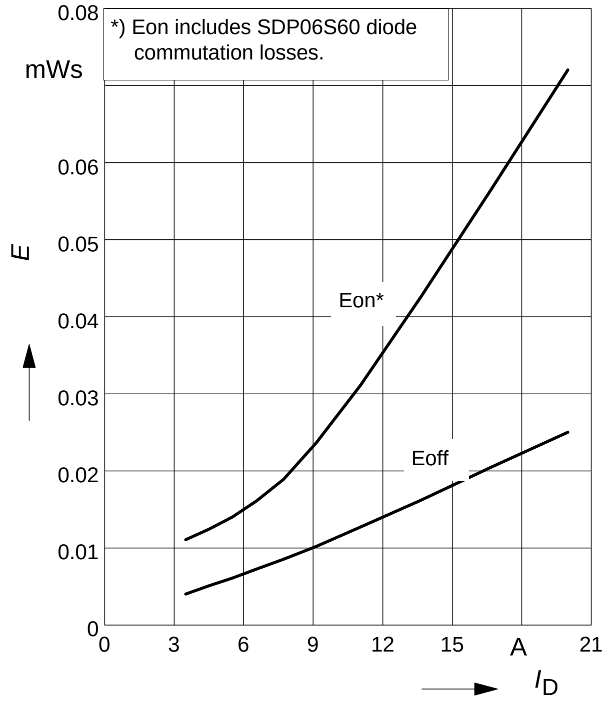
par.: V_{DS}=380V, V_{GS}=0/+13V, I_D=20.7A



16 Typ. switching losses

$E = f(I_D)$, inductive load, T_j=125°C

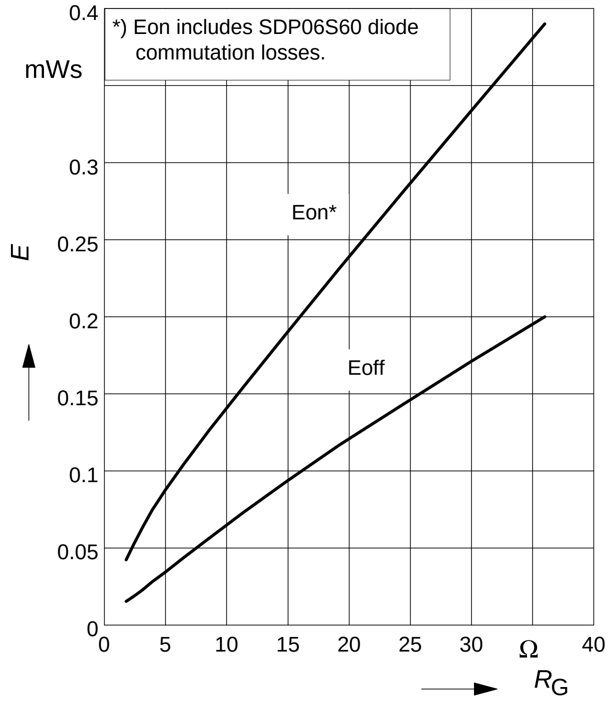
par.: V_{DS}=380V, V_{GS}=0/+13V, R_G=3.6Ω



17 Typ. switching losses

$E = f(R_G)$, inductive load, T_j=125°C

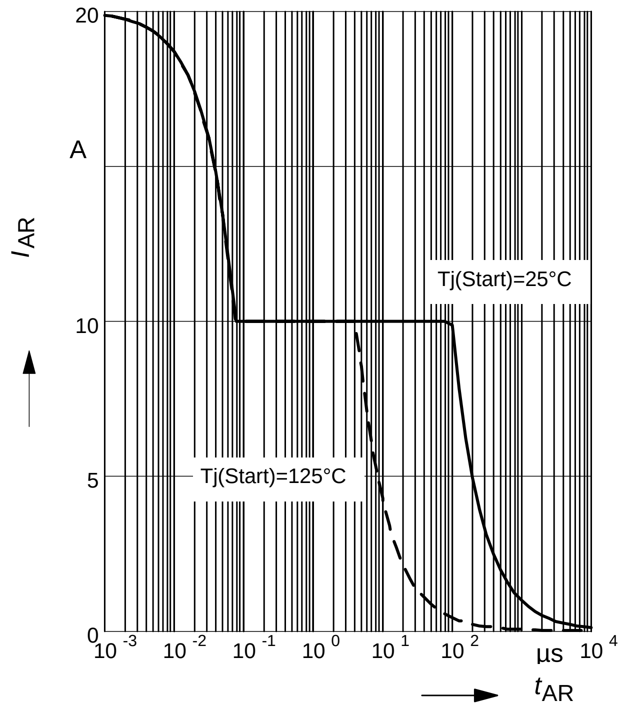
par.: V_{DS}=380V, V_{GS}=0/+13V, I_D=20.7A



18 Avalanche SOA

$I_{AR} = f(t_{AR})$

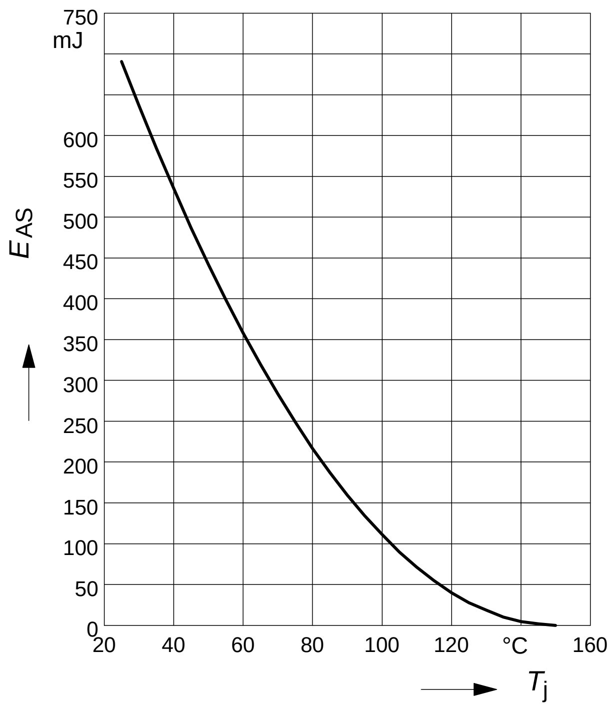
par.: $T_j \leq 150$ °C



19 Avalanche energy

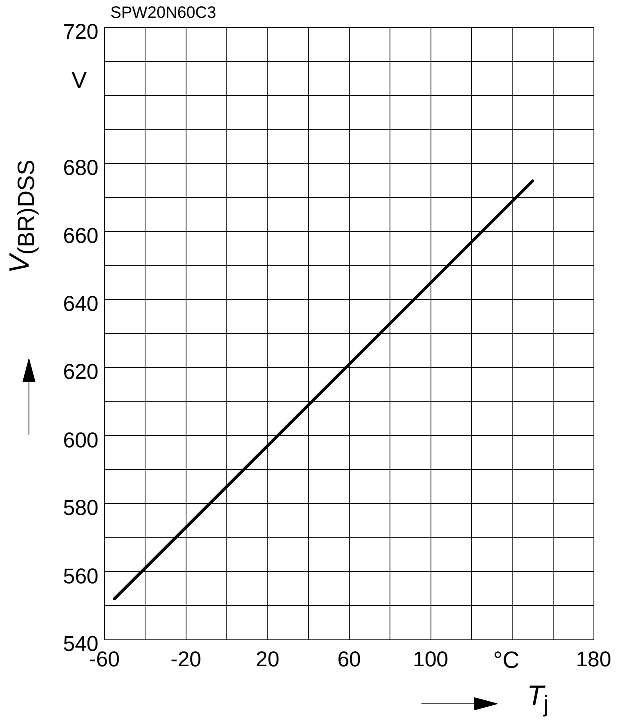
$E_{AS} = f(T_j)$

par.: I_D = 10 A, V_{DD} = 50 V



20 Drain-source breakdown voltage

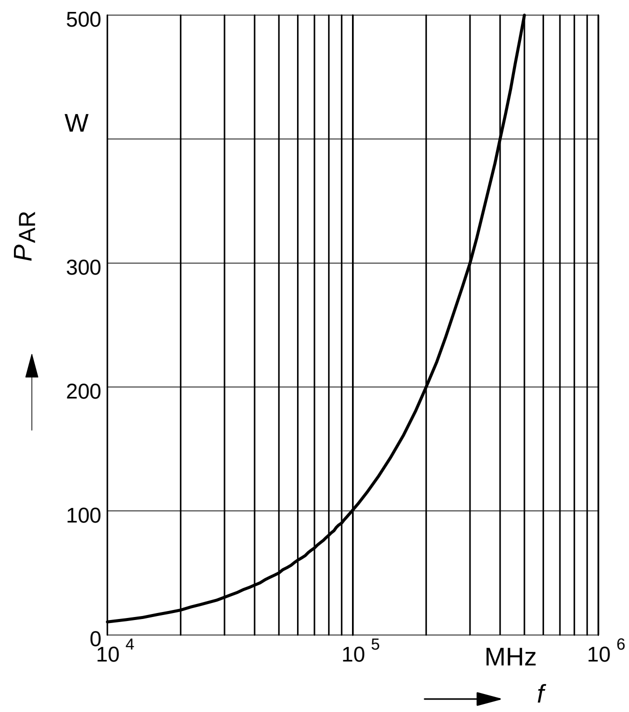
$V_{(BR)DSS} = f\,(T_j)$



21 Avalanche power losses

$P_{AR} = f\,(f\,)$

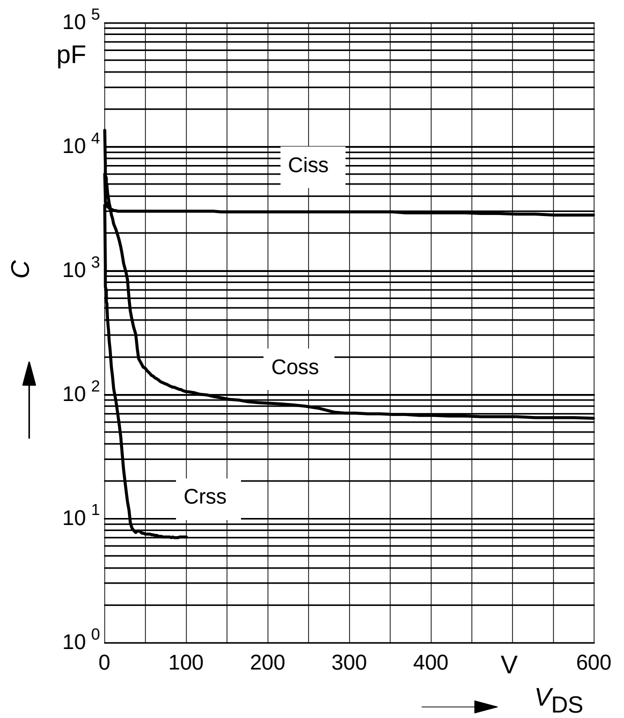
parameter: E_{AR}=1mJ



22 Typ. capacitances

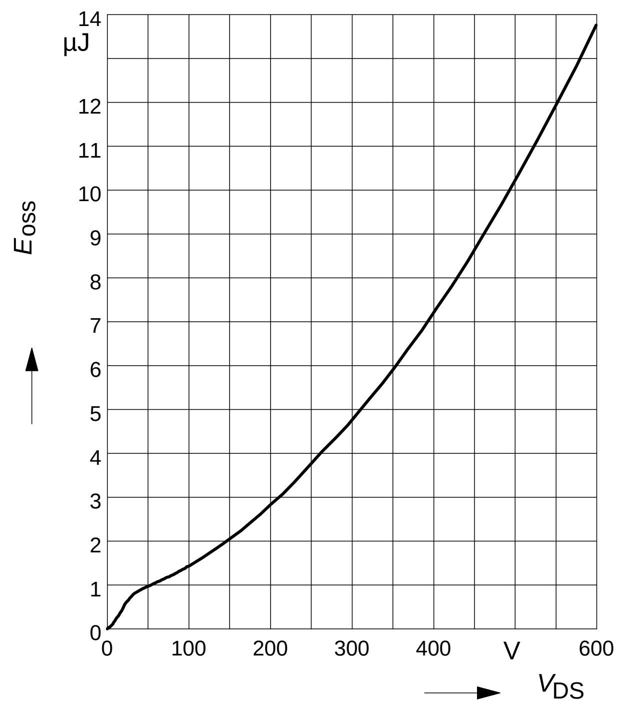
$C = f\,(V_{DS})$

parameter: V_{GS}=0V, f=1 MHz

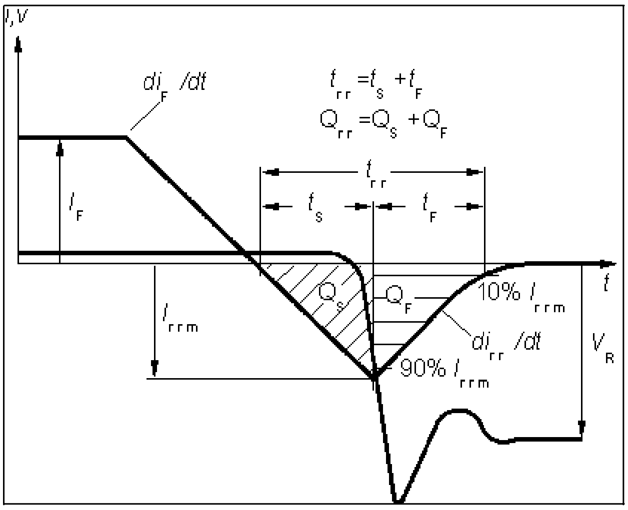


23 Typ. C_{oss} stored energy

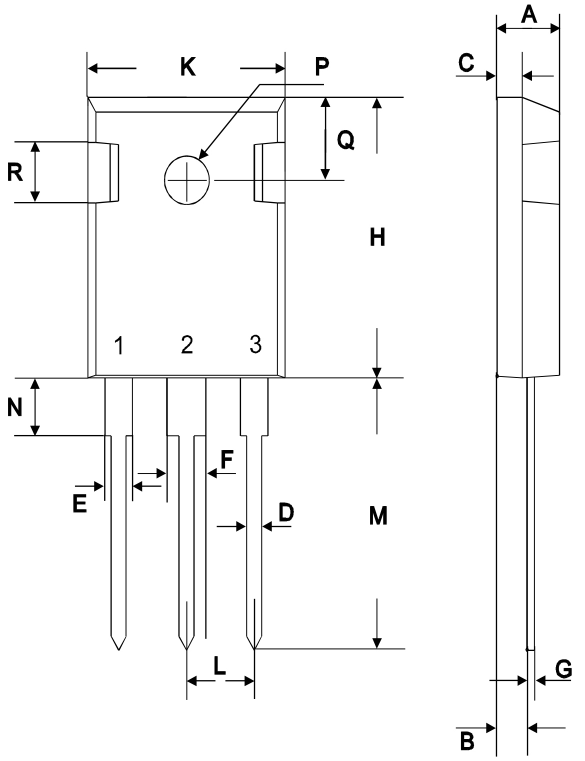
$E_{oss}=f(V_{DS})$



Definition of diodes switching characteristics



TO-247



symbol	dimensions [mm] min	[mm] max	[inch] min	[inch] max
A	4.78	5.28	0.1882	0.2079
B	2.29	2.51	0.0902	0.0988
C	1.78	2.29	0.0701	0.0902
D	1.09	1.32	0.0429	0.0520
E	1.73	2.06	0.0681	0.0811
F	2.67	3.18	0.1051	0.1252
G	0.76 max		0.0299 max	
H	20.80	21.16	0.8189	0.8331
K	15.65	16.15	0.6161	0.6358
L	5.21	5.72	0.2051	0.2252
M	19.81	20.68	0.7799	0.8142
N	3.560	4.930	0.1402	0.1941
∅P	3.61		0.1421	
Q	6.12	6.22	0.2409	0.2449

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